



EUROPEAN UNION



Competitiveness Operational Programme (COP)  
Extreme Light Infrastructure - Nuclear Physics (ELI-NP) – Phase II

# Large aperture LIDT data analysis: preliminary results and current work

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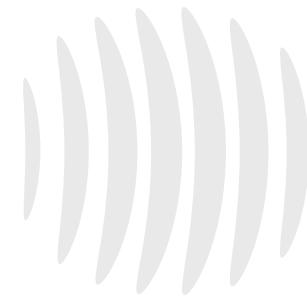
With special thanks to:

Daniel Ursescu, Dan Matei, Gabriel Bleotu, Chauvin Adrien (ELI Beamlines), Daniel Kramer (ELI Beamlines)





# Motivation & previous work in literature



# Motivation & previous work in literature (1)

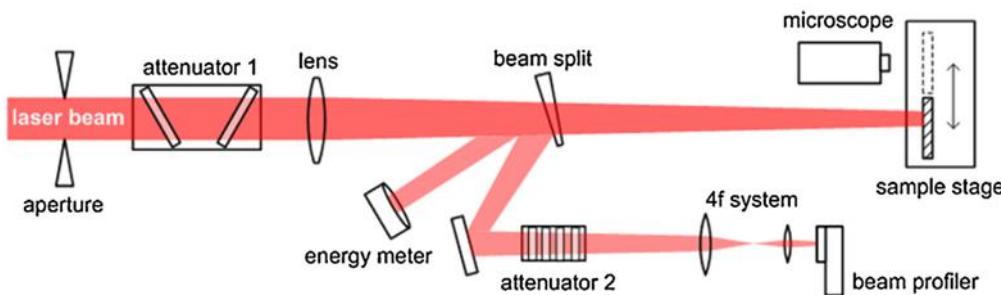


Fig. 1. The structure of single-shot LIDT test bench.

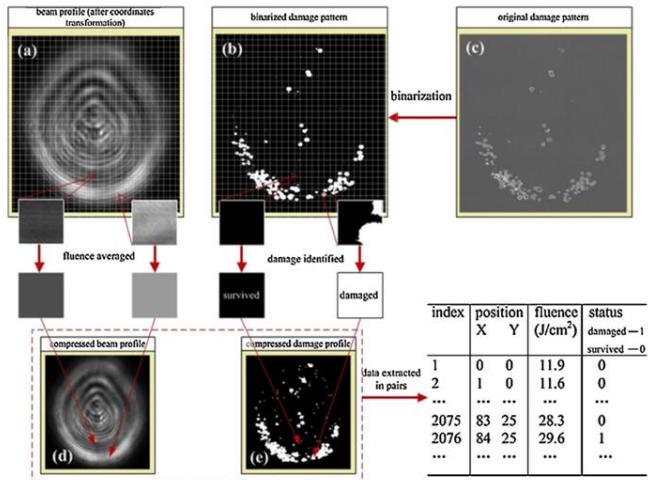


Fig. 4. The damage information extraction procedure. Compression process is performed on the beam profile (a) and damage pattern (b, c). By matching the compressed image of beam profile (d) and damage pattern (e), the damage information could be obtained.

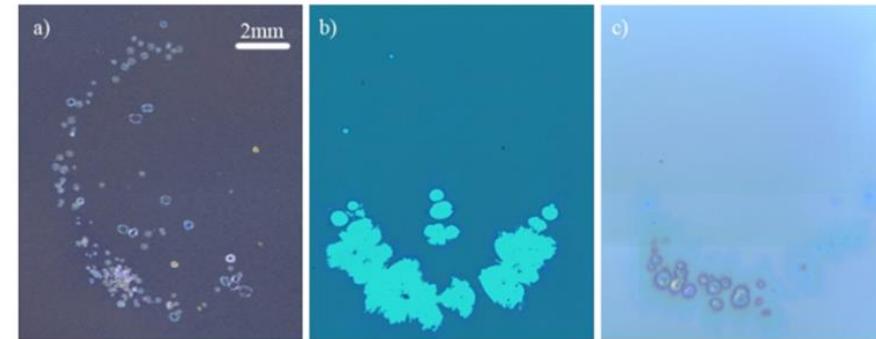


Fig. 5. The typical damage images of (a)  $\text{HfO}_2/\text{SiO}_2$ , (b)  $\text{HfO}_2/\text{Al}_2\text{O}_3$  and (c)  $\text{Ta}_2\text{O}_5/\text{SiO}_2$  under CCD microscopy with single-shot.

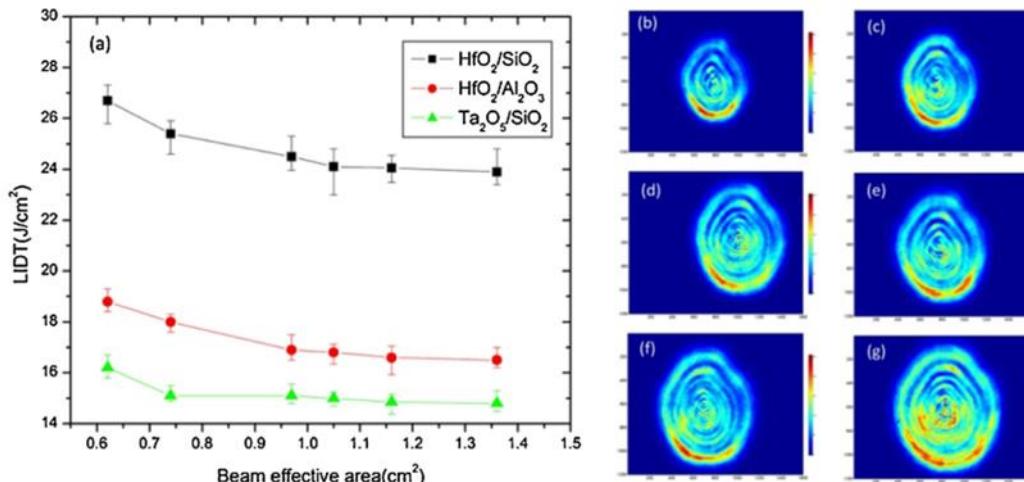


Fig. 10. The relationship between LIDTs and beam size on three type coatings.

Z. Liu, Y. Zheng, F. Pan, Q. Lin, P. Ma, and J. Wang, "Investigation of laser induced damage threshold measurement with single-shot on thin films," *Applied Surface Science*, vol. 382, pp. 294–301, Sep. 2016, doi: 10.1016/j.apsusc.2016.04.093.

# Motivation & previous work in literature (2)

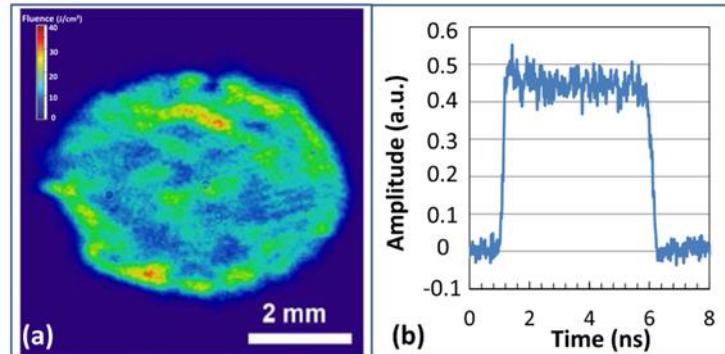


FIG. 3. (a) Spatial profile of the 7.3 mm diameter beam at the sample plane as measured by a CCD camera. The beam contrast is about 20%. (b) The corresponding typical Flat-In-Time (FIT) temporal profile at 351 nm of around 5 ns.

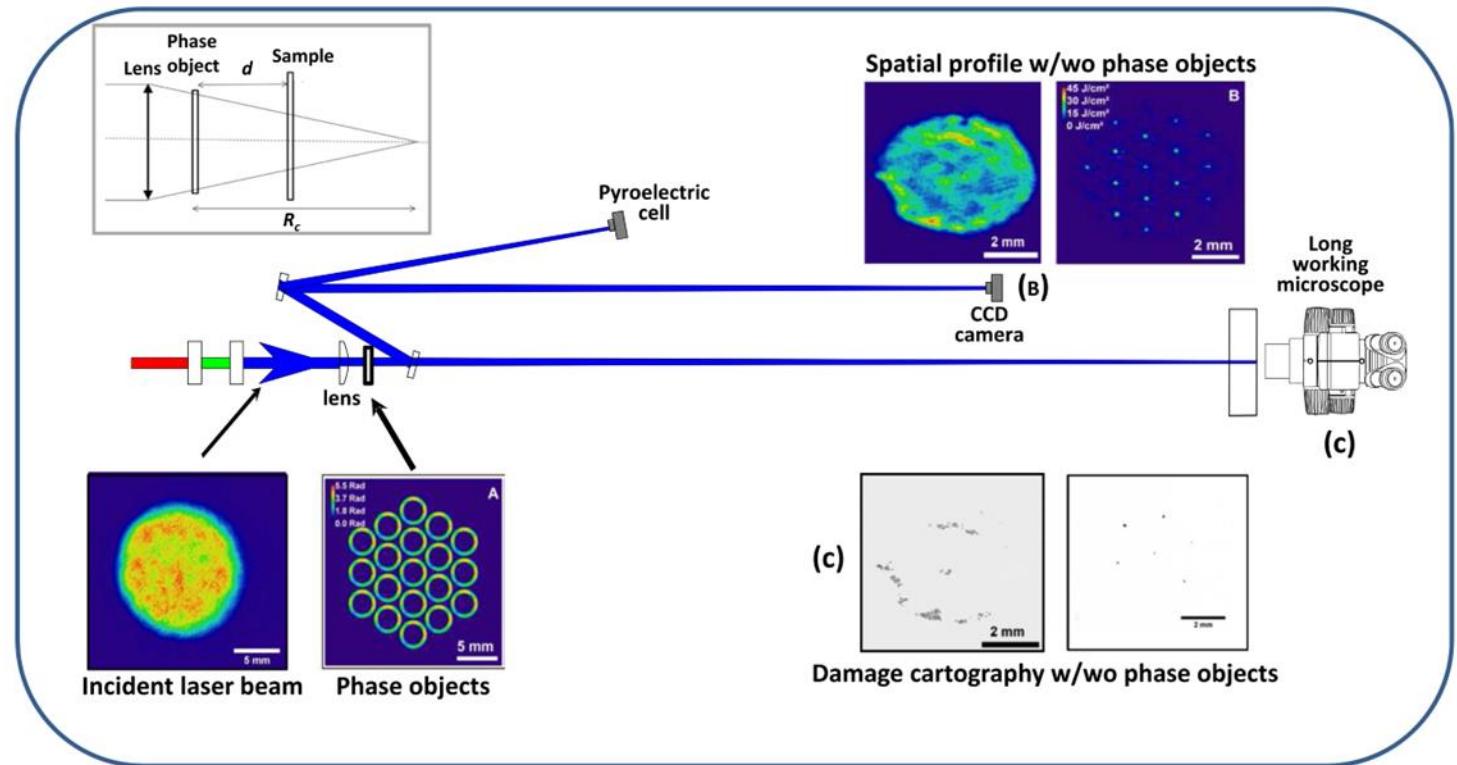


FIG. 2. Simplified experimental setup: Phase objects (A) are inserted between the focusing lens and a beam splitter that directs a part of the beam to diagnostics. A CCD camera (B) records the spatial profile on a plane equivalent to the sample plane. After each shot a long working distance microscope observes the irradiated area (C). The inset illustrates the focusing beam and the main distances.

L. Lamaignère et al., “A powerful tool for comparing different test procedures to measure the probability and density of laser induced damage on optical materials,” *Review of Scientific Instruments*, vol. 90, no. 12, Art. no. 12, 2019, doi: 10.1063/1.5122274.

Lack of knowledge can be... expensive



Diffraction pattern shaped damage



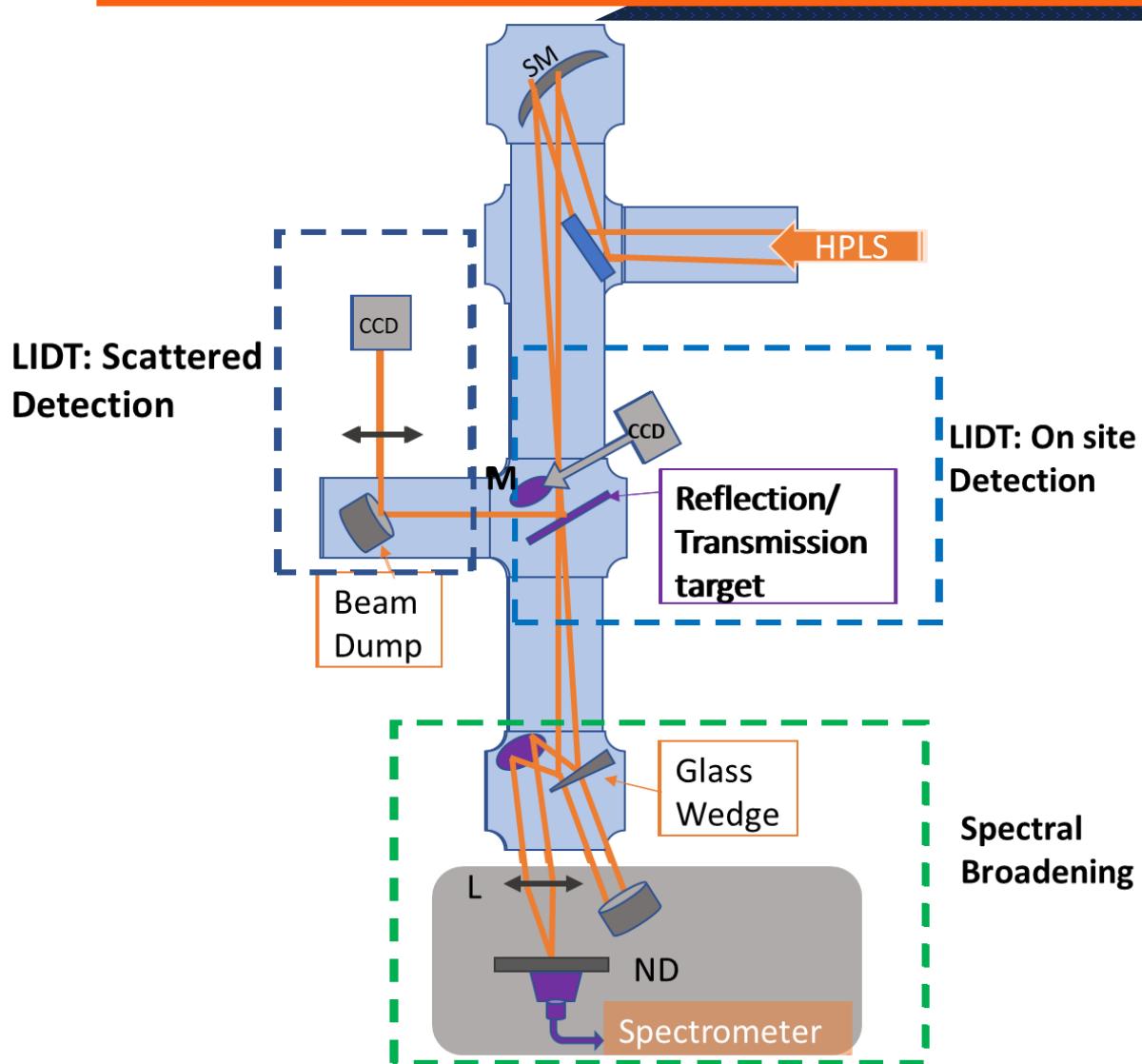
Small exfoliation

Large aperture LIDT is mandatory!

# Experimental setup



# Experimental setup



## Detection methods for LIDT:

Microscope (large spots)

Nomarski Microscope

## Samples:

Mirror 1 (Ag+3 layers SiTiO<sub>2</sub>), Mirror 2 (Ag+1 layer SiO<sub>2</sub>), 2 Chirped mirrors, FS, IDEX 2, IDEX 4, LASEROPTIK, Optoman, Optosigma, ZEONOR

**Nr of shots:** 1, 10, 100, 1000, 10000

**Energy:** 8 mJ-160 mJ

**Spot size:** 3-7 mm

**Pulse duration:** 25 fs

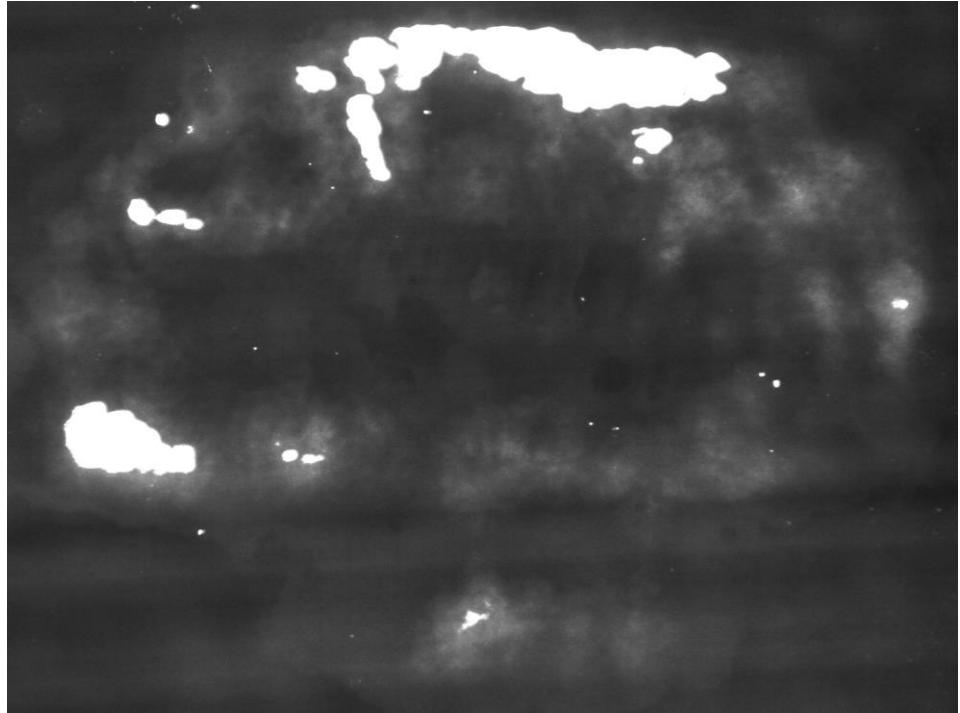
**Parabola** 1.2 m

**Experimental team:** Gabriel Bleotu, Alice Dumitru, Cristian Alexe, Andrei Naziru, Stefan Popa, Dan Matei, Daniel Ursescu (ELI-NP), Tamas Somoskoi (ELI-ALPS)

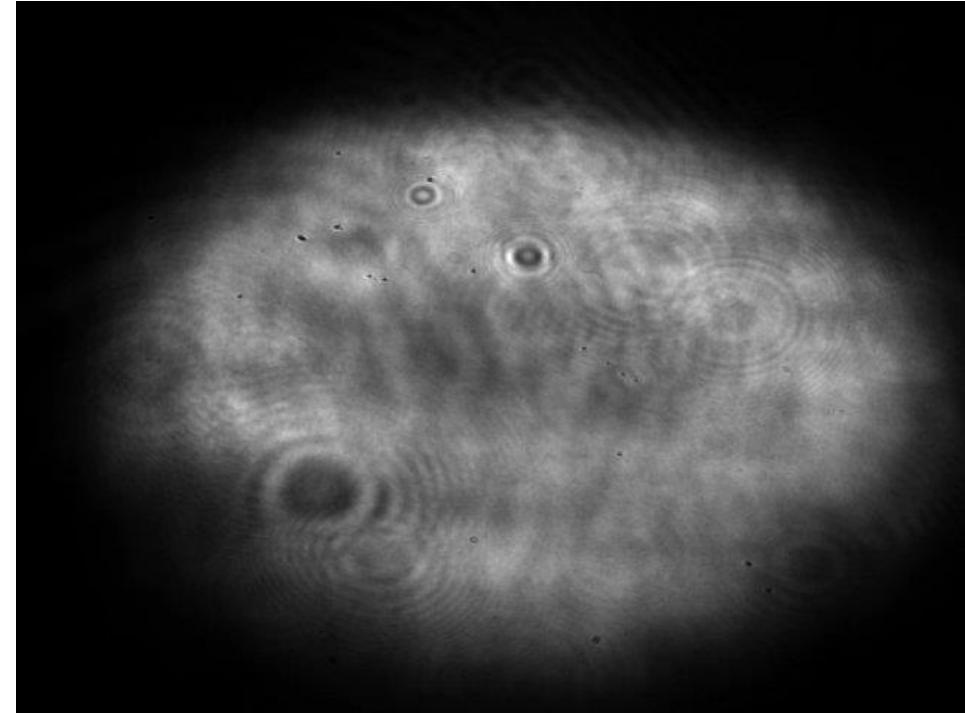


# Preliminary data analysis





Damage image (from optical microscope)



Laser beam profile

Damage



Binarising

Bordering

Overlap analysis

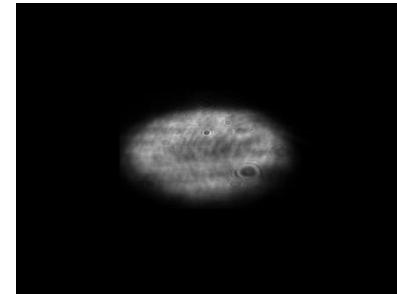
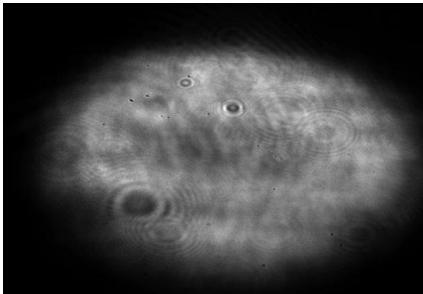
Rotation

Bordering

Resizing

Translation

Laser



Why?

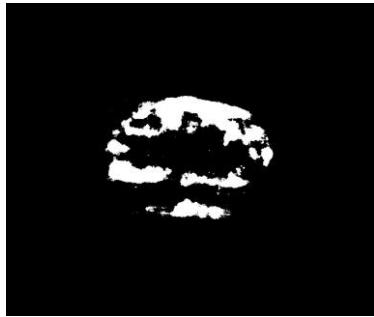
- This ensures the profiles are of the same size, as the camera pixel size can differ from the size on the detector.

What?

- This algorithm finds the optimal parameters for resizing (with reference (0,0)) the laser intensity profile.

How?

- Variables to optimise: resizing parameters, intensity threshold.



Binarising

Bordering

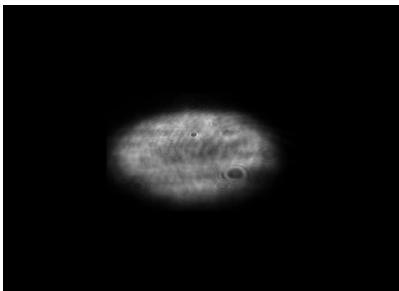
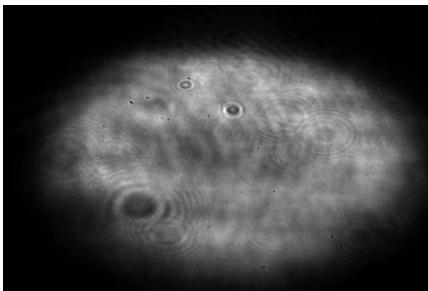
Overlap analysis

Rotation

Bordering

Resizing

Translation





Binarising

Bordering

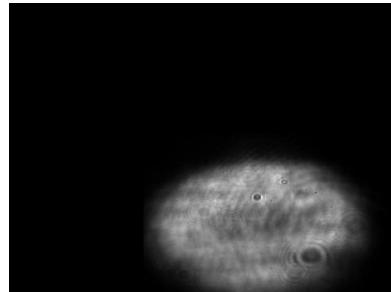
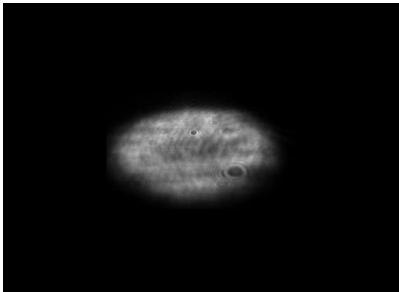
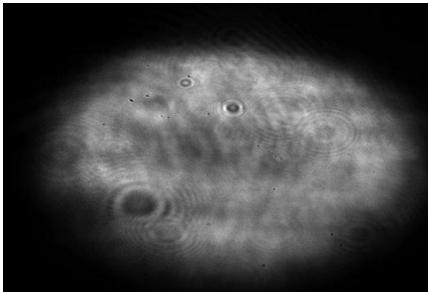
Overlap analysis

Rotation

Bordering

Resizing

Translation



Why?

- This ensures that for the data analysis part of the algorithm, the two images match in position.

What?

- This algorithm finds the optimal parameters for translation.

How?

- The variable to be optimized: number of laser pixels above intensity threshold matching with damaged pixels.



Binarising

Bordering

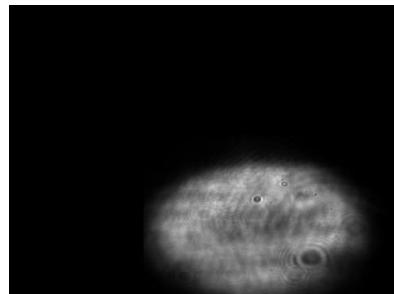
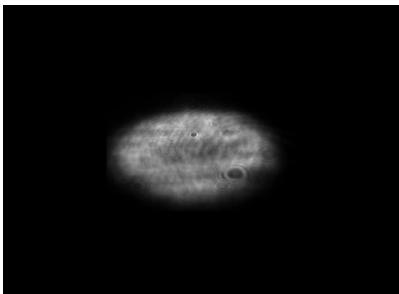
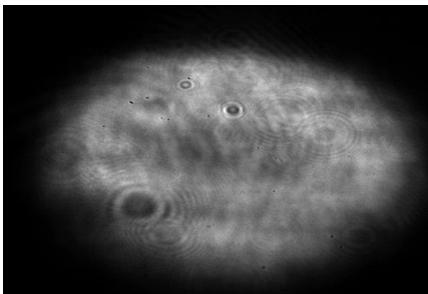
Overlap analysis

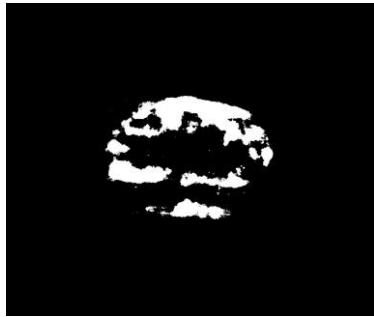
Rotation

Bordering

Resizing

Translation





Binarising

Bordering

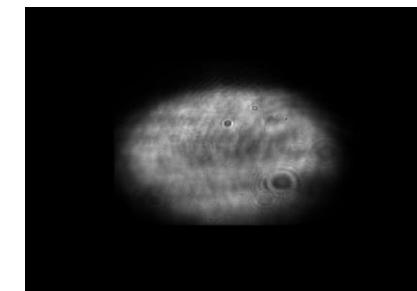
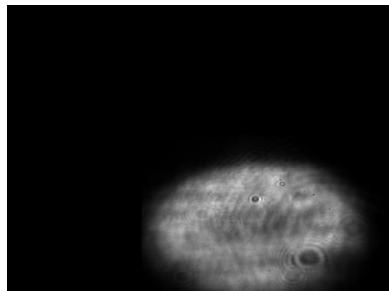
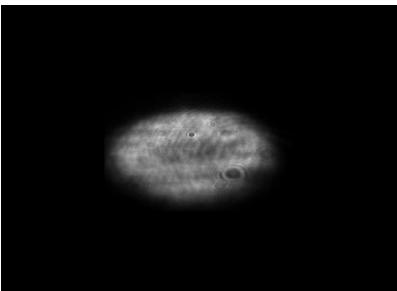
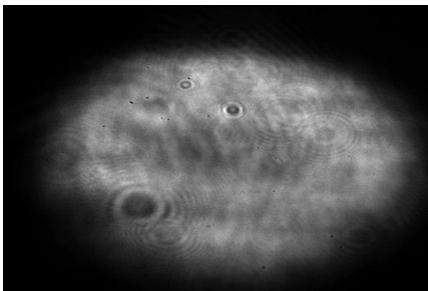
Overlap analysis

Rotation

Bordering

Resizing

Translation



# LIDT data analysis: program components



Binarising



Bordering



Rotation



Bordering

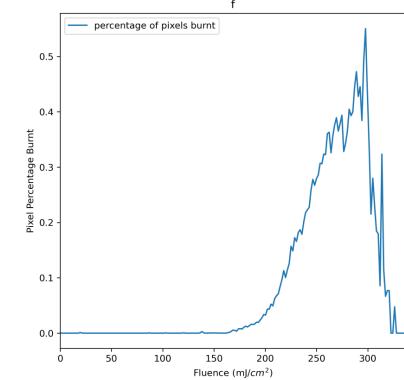


Resizing

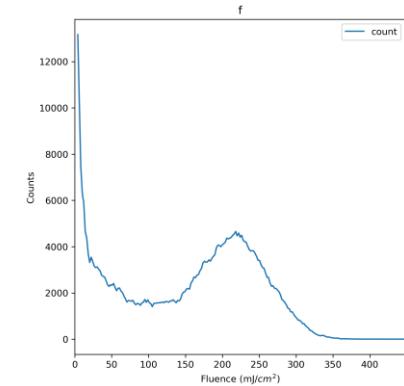


Translation

LIDT curve



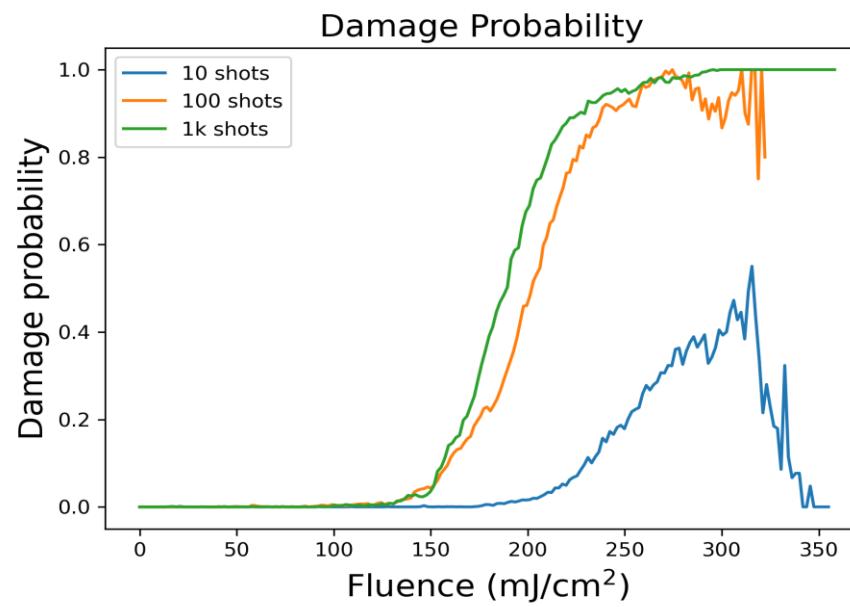
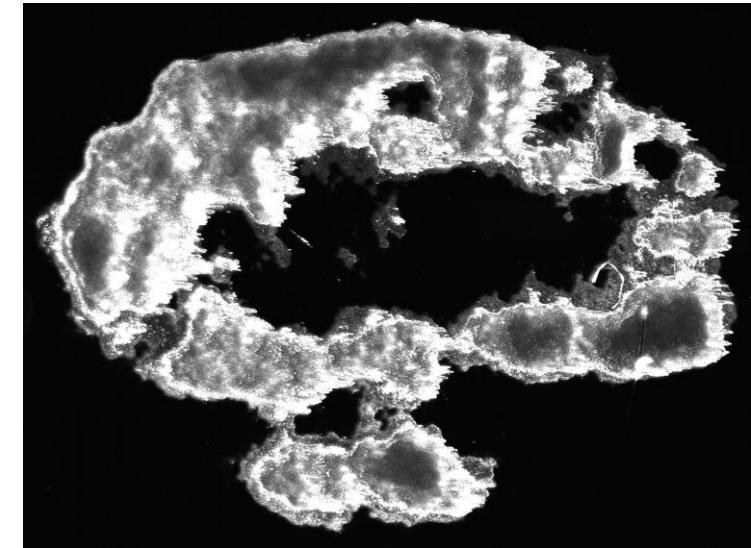
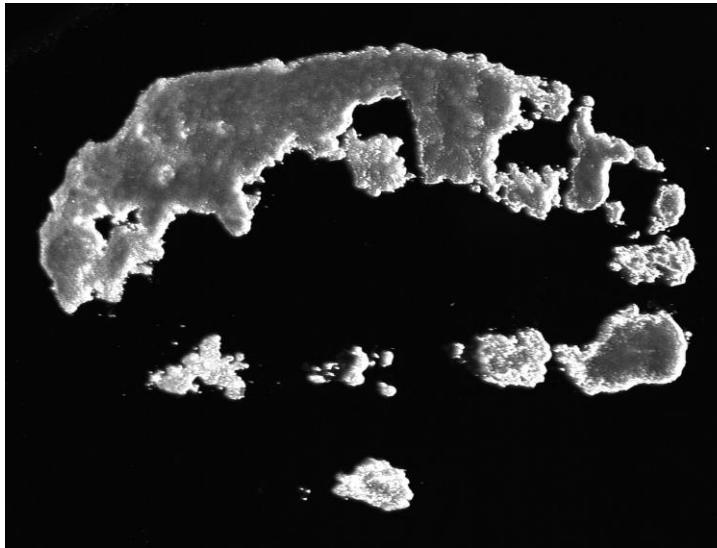
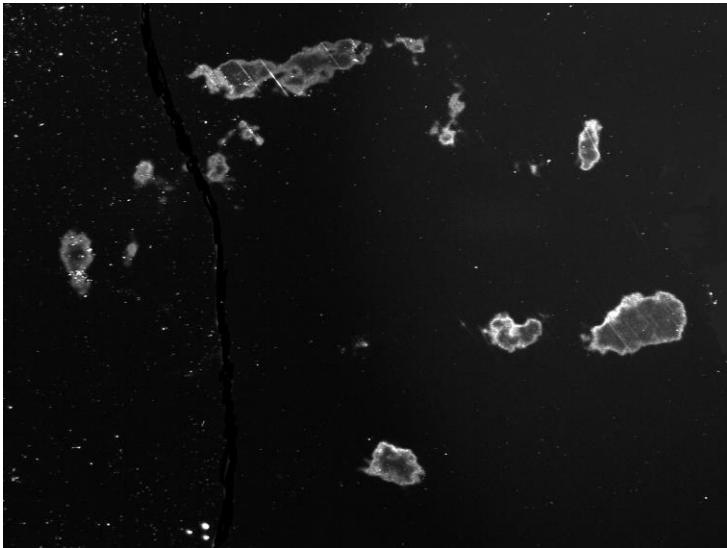
Overlap analysis

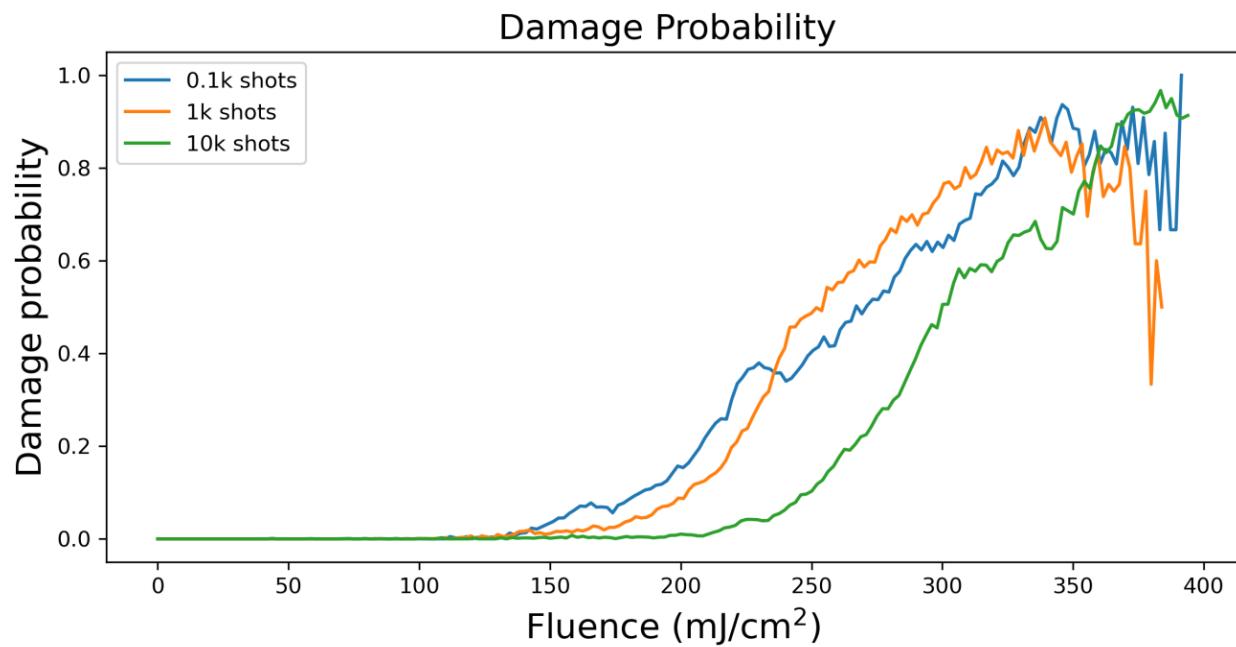
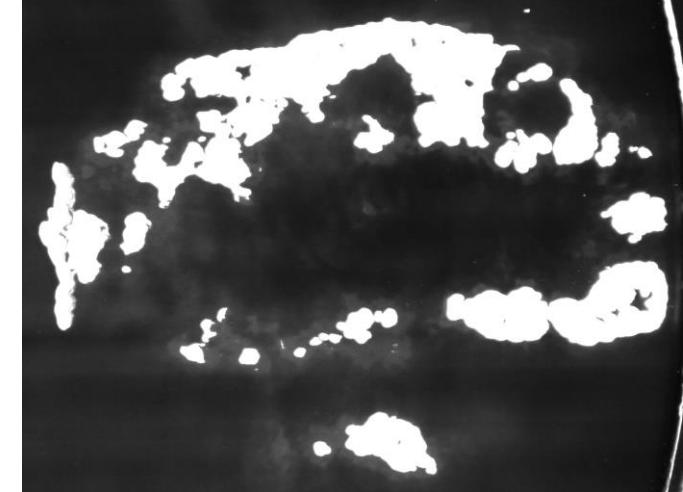
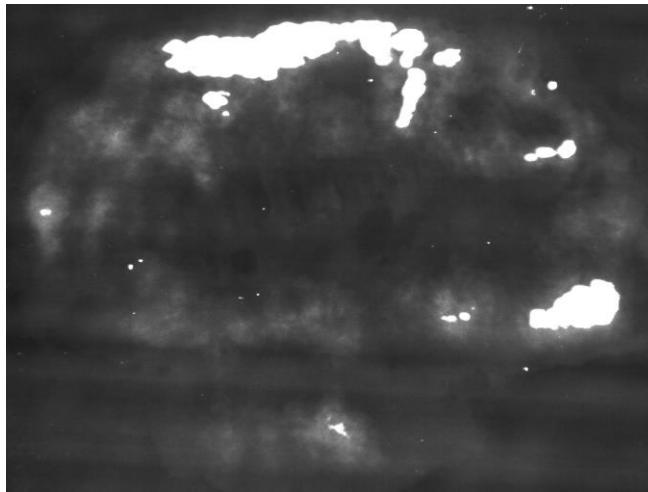
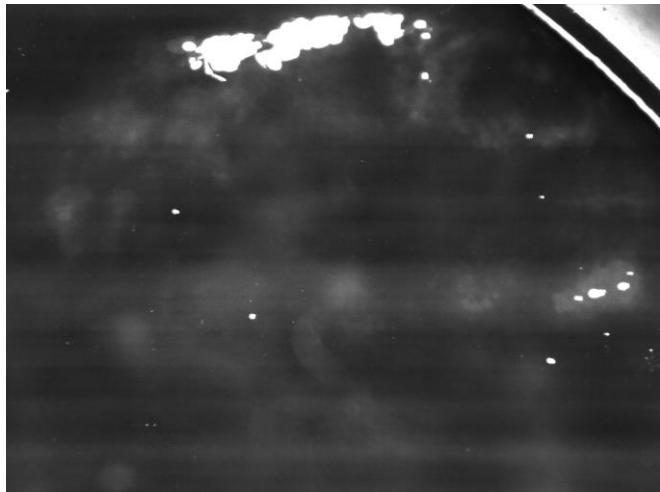


Laser profile histogram

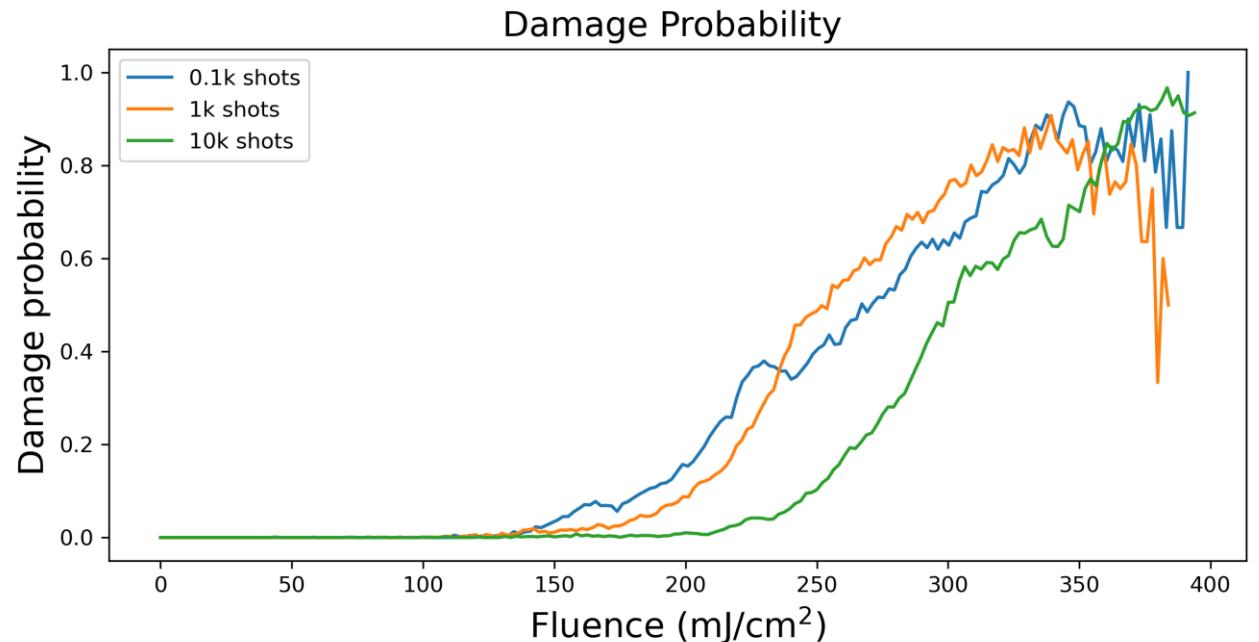
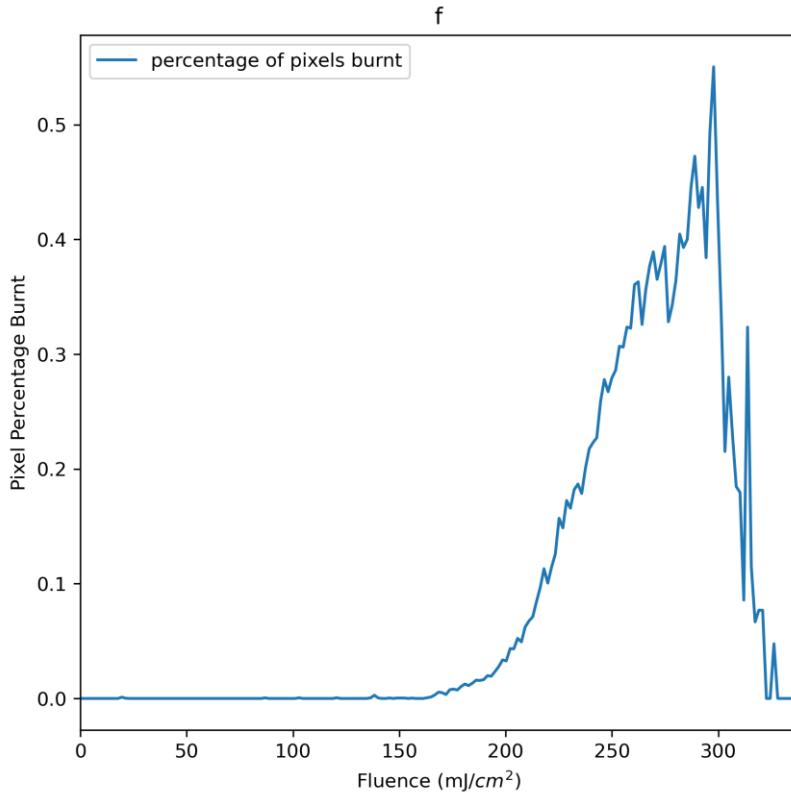
Sample Analysed	Number of shots	Observations
Ag (SiO <sub>2</sub> )	10	The damage profile was well defined, hence the LIDT curves were less noisy and with much clearer boundaries between damaged and undamaged.
Ag (SiO <sub>2</sub> )	100	
Ag (SiO <sub>2</sub> )	1000	
CMHT	500	Due to less well defined damage (and poorer picture quality), the curves are also less well defined and have a lot more noise.
CMHT	1000	
CMHT	10000	

# Ag ( $\text{SiO}_2$ ): 10, 100, 1k shots





- Current results are promising, but...



Accuracy < 75%, noise+can't estimate total damage threshold.

Some results seem to be... inconsistent



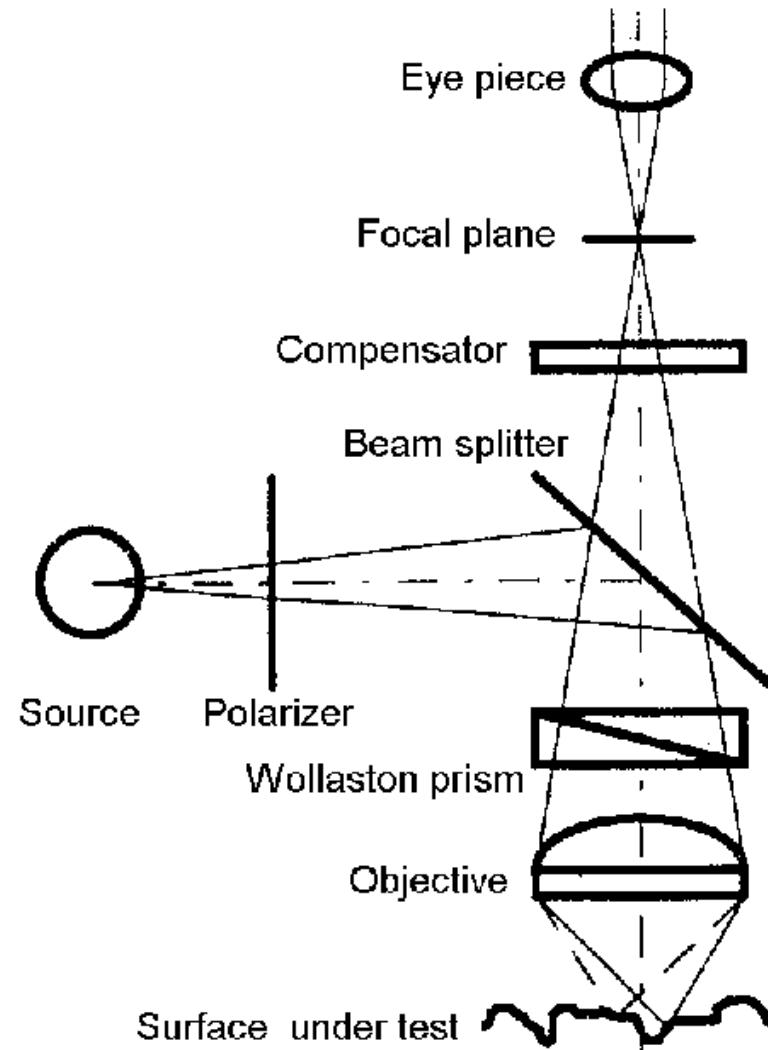
# Current work & outlook



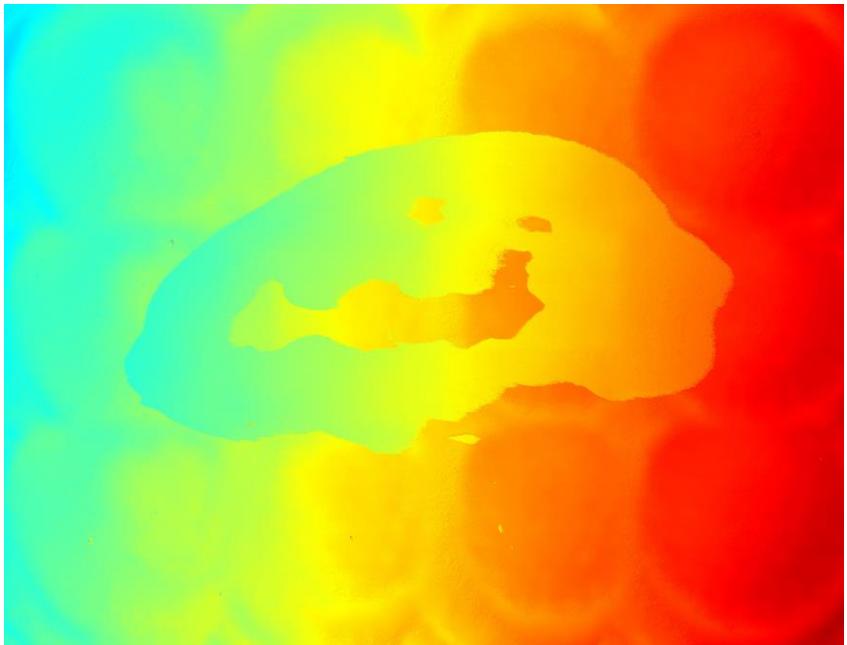
# Nomarski microscope

With special thanks to:  
Chauvin Adrien  
Daniel Kramer  
from ELI Beamlines

(Differential interference  
contrast microscopy)



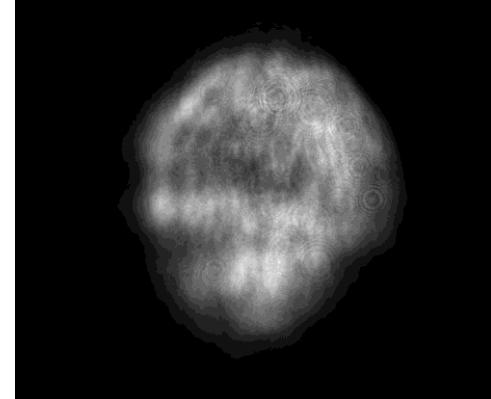
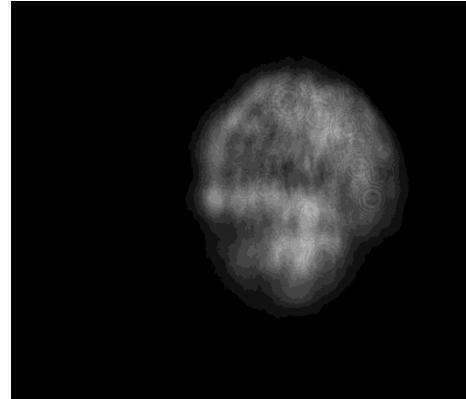
Damage profile



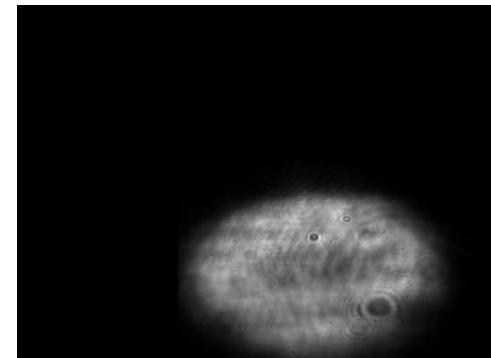
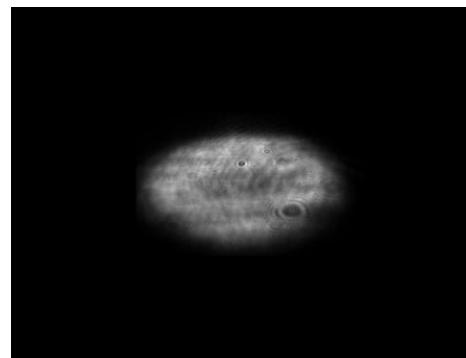
Quite intense periodic noise patterns!

TBD: Rotation algorithm,  
neglected due to relatively small  
errors from lack of one and  
inefficiency time wise. (<4%)

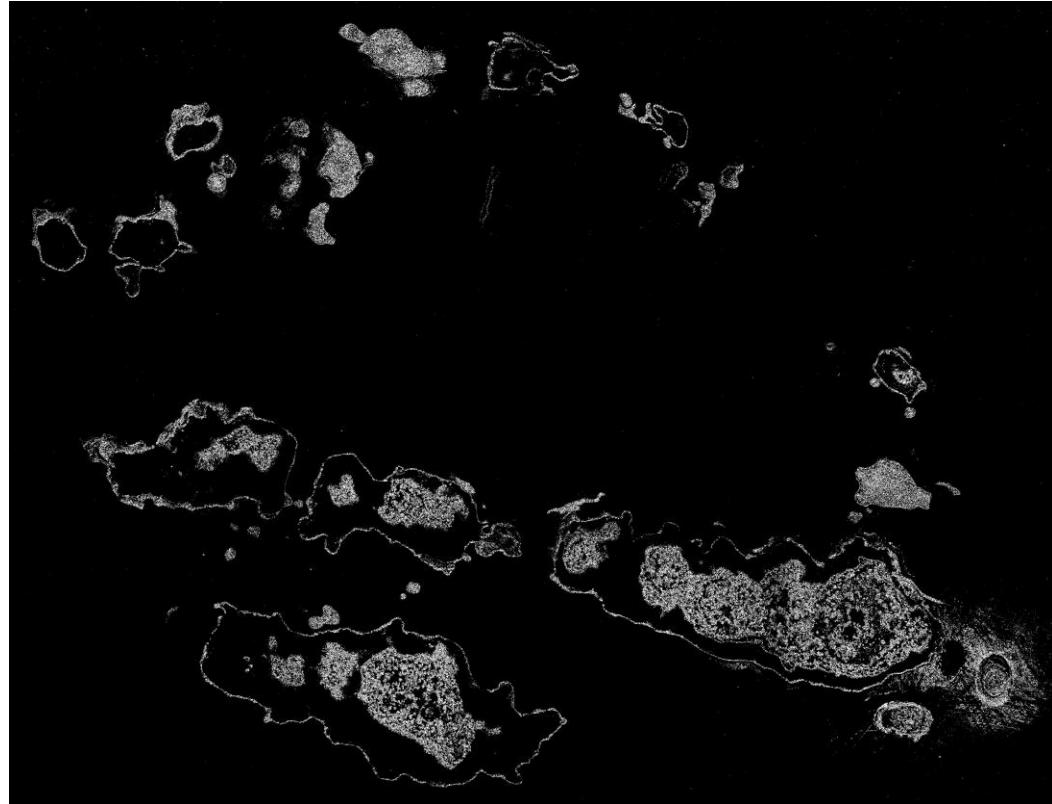
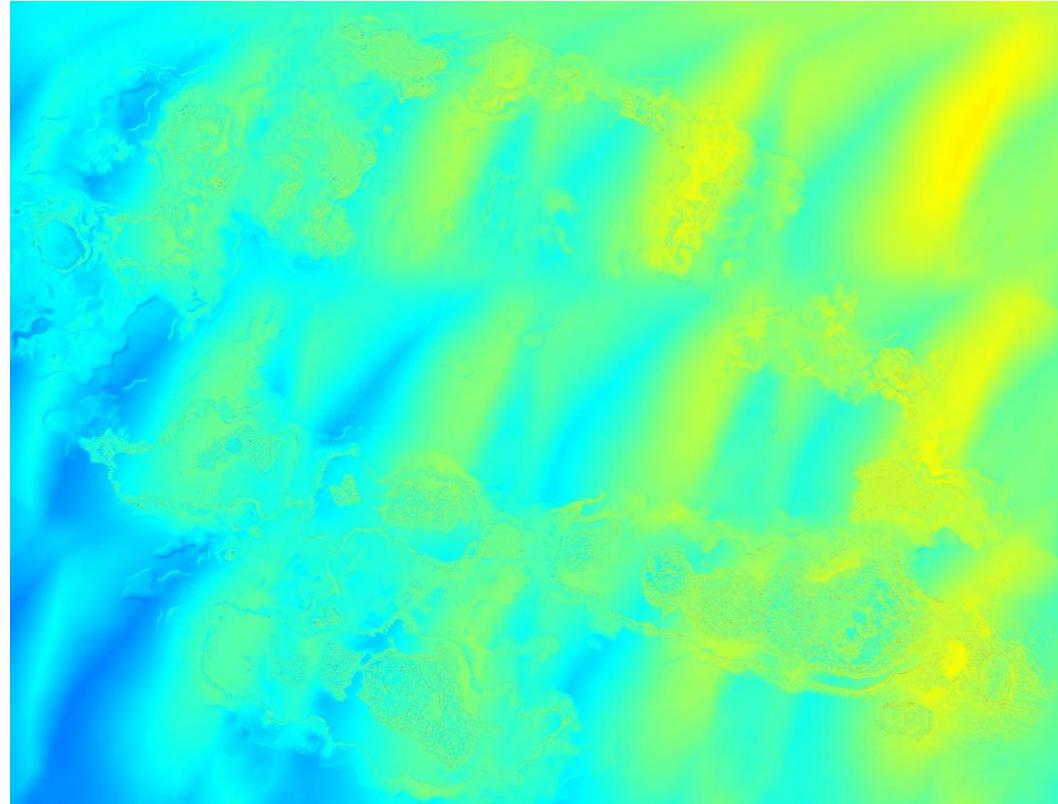
Laser profile



Defocus changes laser profile size, also energies per shot/angle of sample were different.

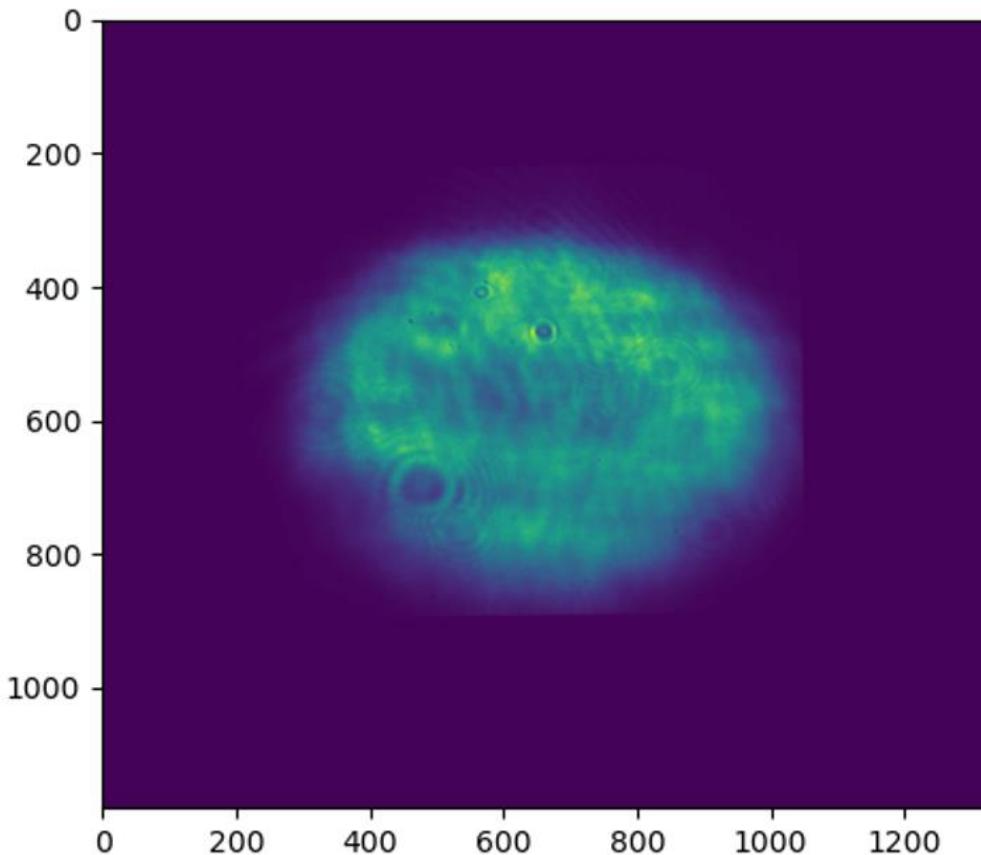
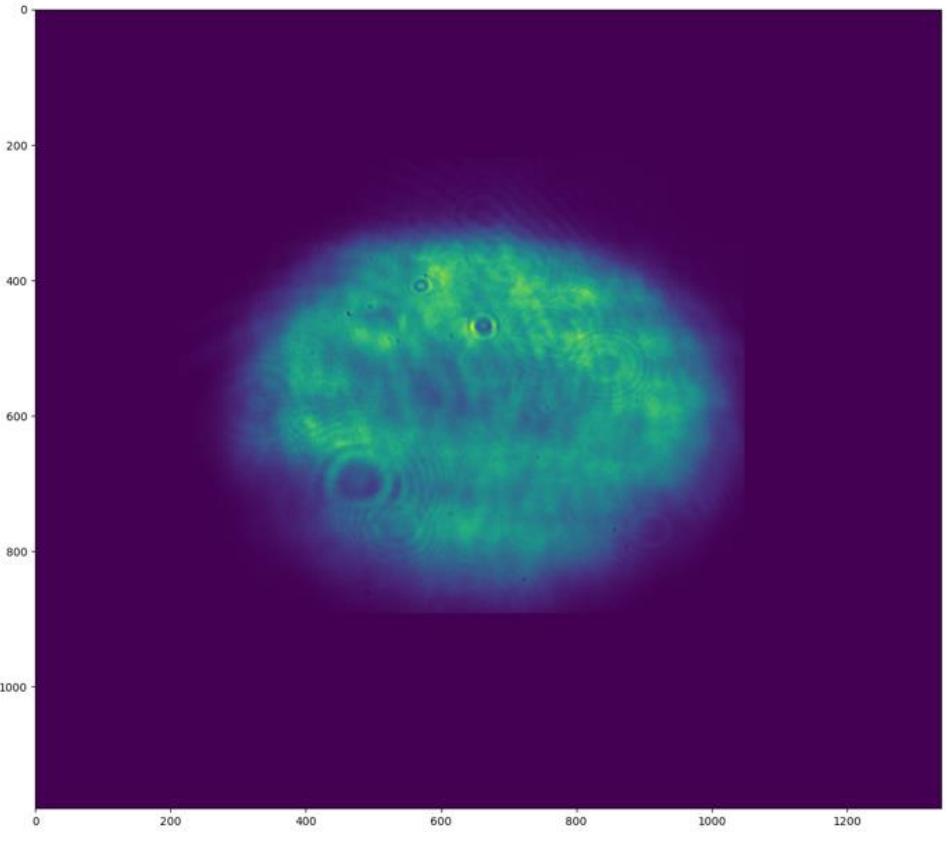


Resizing program isn't very accurate, and now we have both the laser profile and damage with real coordinates.



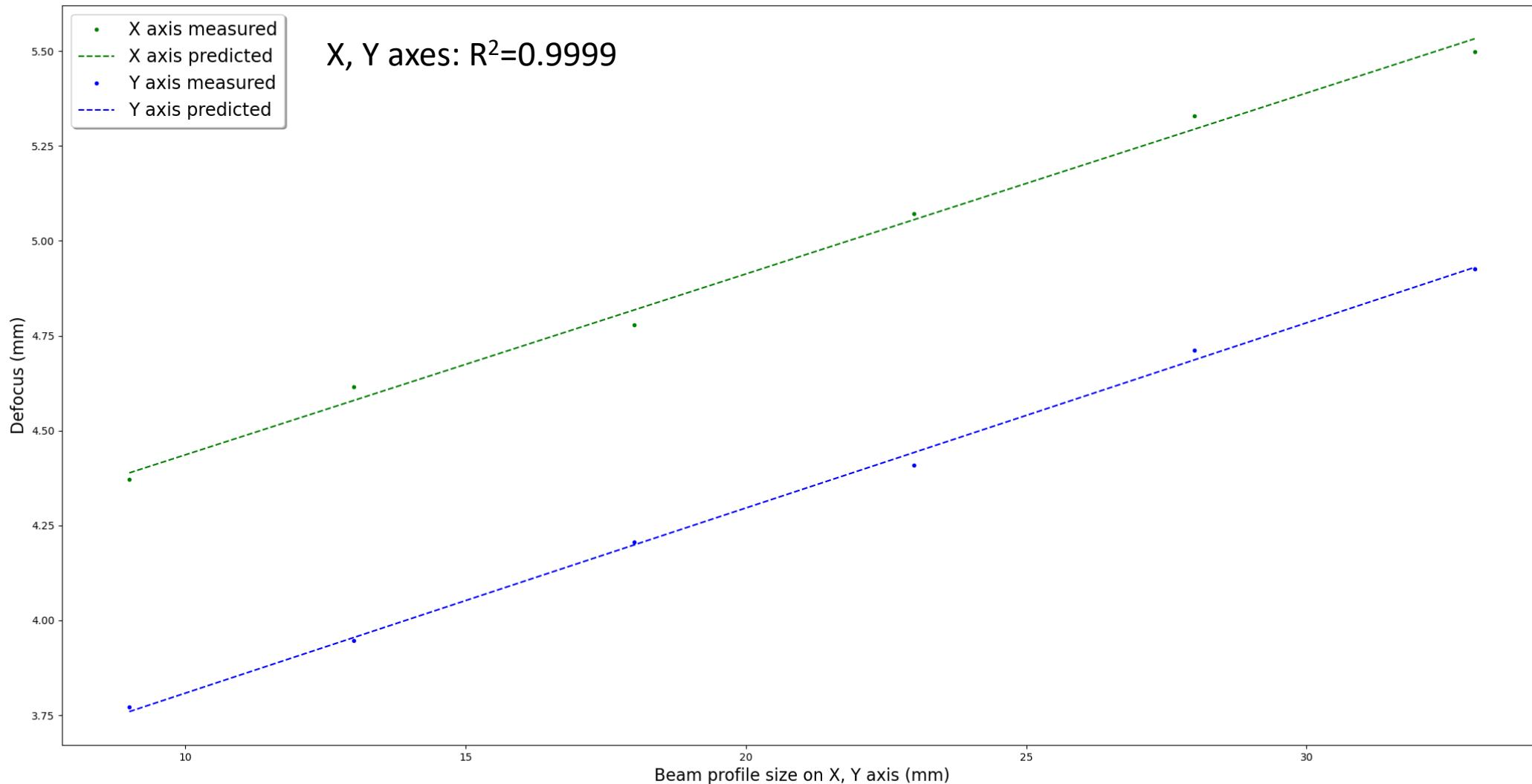
Too much noise? Use a Laplacian! (and a high enough threshold for the Laplacian values)

# Current work: new rotation algorithm



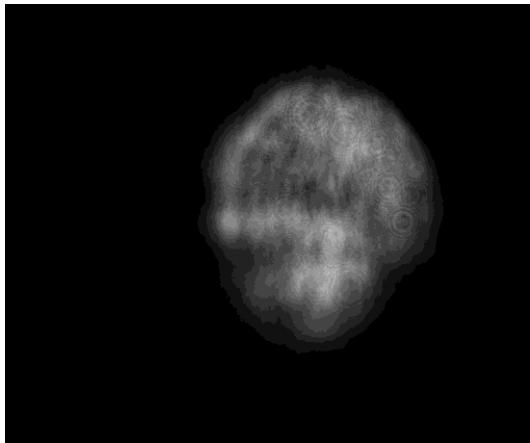
Our rotation was off only by 0.0122 radians (0.7 degrees) to the optimal one, accuracy only improved by 0.12%! (85.52->85.66%)

# Current work: dependence on defocus



```
imageProperties::imageInfo::phase::group::channel::length::x[0] 2.5153344178579338
imageProperties::imageInfo::phase::group::channel::length::x[1] 2.5153344178579338
imageProperties::imageInfo::phase::group::channel::length::x[2] 2.5153344178579338
imageProperties::imageInfo::phase::group::channel::length::y[0] 2.5001120507412447
imageProperties::imageInfo::phase::group::channel::length::y[1] 2.5001120507412447
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imageProperties::imageInfo::phase::group::channel::length::z[1] 0.008093946315729
imageProperties::imageInfo::phase::group::channel::length::z[2] 0.008093946315729
```

Pixel size values from Nomarski microscope in  $\mu\text{m}$



Camera pixel size:  $3.45 \mu\text{m} \times 3.45 \mu\text{m}$

For each axis:

Resizing factor = 
$$\frac{\text{Pixel size of damage profile}}{\text{Pixel size of laser profile (3.45 } \mu\text{m)}}$$

- First large aperture LIDT experiment performed with fs laser pulses;
- Data analysis provided results for Ag ( $\text{SiO}_2$ ) and chirped mirrors.
- Large aperture LIDT will yield much better statistics -> better characterisation of damage thresholds for materials, possibly uncover damage mechanisms;
- Work in progress: better algorithms, better damage and laser image
- The results should help in characterizing damage more accurately, control it better, reducing the risk of damage and pushing the boundaries further with any current or future experimental setups to higher powers.
- Possible use in testing mirrors produced by the upcoming COMP facility at ELI-NP.